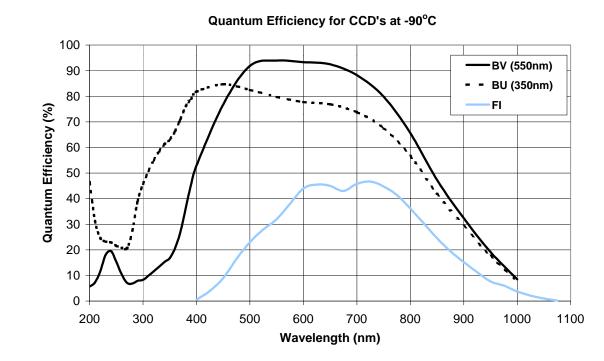


Andor's DU440 CCD is designed to offer the best performance characteristics over a wide range of spectroscopy applications. The 2048 x 512 array camera is ideally suited to rapid, multi-channel, low-light applications including fluorescence and Raman spectroscopy, where high resolution is important. The system boasts negligible dark current with thermoelectric cooling down to –90°C.

●Sensor	Active Pixels	2048 x 512	Dummy Pixels* ¹	50, 50, 0, 0	
	Pixel Size (µm)	13.5	Image Area (mm)	27.6 x 6.9	
	Pixel Well Depth (e, typical)	80,000	Register Well Depth (e, typical)	•2 600,000	
	Linearity (%, maximum)*3	1	Gain (e/count @ 1&2, 16, 32 µ	s) 2, 1.4, 0.7	
	Vertical Clock Speed (µs)	16			
	<u>.</u>				
●Noise	System Readout Noise (e [.])*4	Typical	Maximum:		
	31kHz pixel readout rate	3	4.5	4.5	
	1MHz pixel readout rate	10	15		

Quantum Efficiency

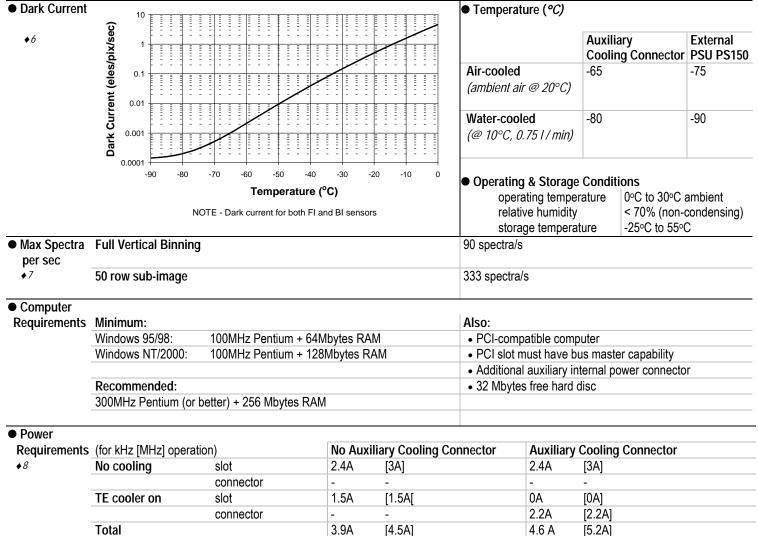


Peak Quantum Efficiency at room temperature [-90°C] (%)*5

CCD Type		Minimum	Typical
FI	@ 700 nm	40	47 [46]
BU	@ 400 nm	80	90 [82]
BV	@ 550 nm	85	95 [94]



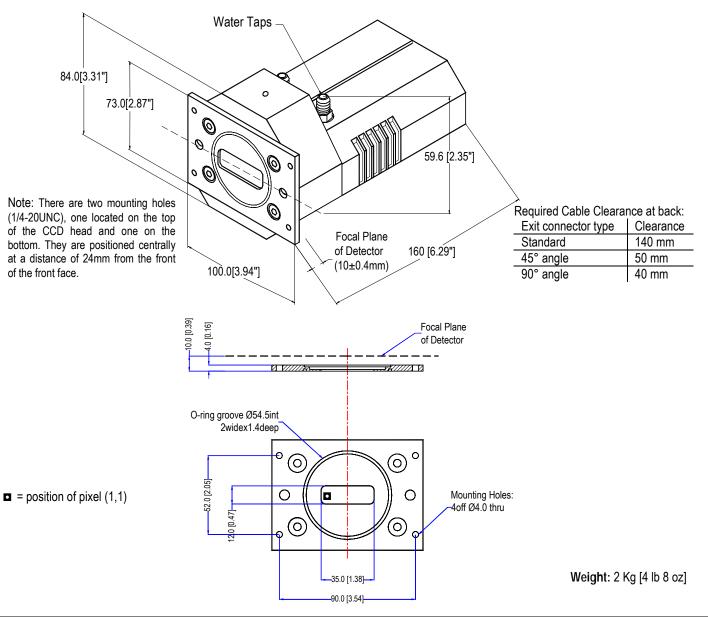
Features & Benefits	Peak QE of 95%	High detector sensitivity
	Min operating temp of –90°C with TE cooling	Negligible dark current without the nuisance or safety concerns associated with LN2
	Guaranteed hermetic vacuum seal	Ultimate reliability and sustained lifetime performance characteristics
	Front- or back-illuminated design	Offers the best price/performance options
	13.5 x 13.5µm pixel size	Optimised pixel size for dynamic range and high resolution
	Andor-MCD Software	Friendly Windows user interface offers system integration, automation and advanced data manipulation facilities



Total

(Power drawn from +5V power supply; Optional external power supply (PS150) plugs into the mains)





• For complete system use with...

The DU440 requires one of the following controller card options

CCI-001 PCI Controller card with 16-bit 62KHz & 31KHz pixel readout rate options

CCI-010 PCI Controller card with 16-bit 1MHz, 500KHz, 62KHz & 31KHz pixel readout rate options

The DU440 also requires one of the following software options.

Andor-MCD software – a ready-to-run Windows 95, 98, 2000, ME or NT -based package with rich functionality for data acquisition and manipulation

Andor-SDK-CCD - a DLL driver and software development kit that lets you create your own applications for the Andor camera

The DU440 may be used with the following accessories PS150 Power Supply Module for achieving the lowest temperatures IO160 Breakout box for interface signals LM-NIKON-F Nikon F-mount lens adaptor LMS-NIKON-F Nikon F-mount lens adaptor with shutter

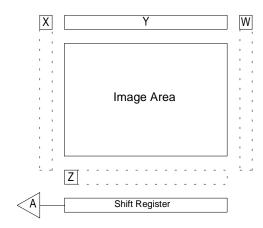
Contact Andor for details of spectrographs and adapters that can be used with the DU440. Contact details on back page.





- Chip manufacturers may include a number of pixels or elements that are ♦1 neither active nor part of the shift register. Andor refers to these pixels as dummy pixels and represents them in a 4-part notation (W, X, Y, Z), where:
 - W = dummy pixels to the right of the shift register (non-amplifier end)
 - X = dummy pixels to the left of the shift register (amplifier end) Y = dummy pixels at the top of the image area
 - Z = dummy pixels between the shift register and the image area.
 - A = position of output amplifier

It should be noted that the elements can be made up of either pixels, rows or columns. The diagram shows what is seen when looking at the front of the CCD.



- ♦2 The register well depth that is actually accessible by the CCD system is dependant on the gain setting.
- Linearity is measured from a plot of Counts vs. Signal over the 16 bit dynamic range. Linearity is expressed as a percentage deviation from a ♦3 straight line fit. This value is not measured on individual systems.
- System Readout noise is for the entire system. It is a combination of CCD readout noise and A/D noise. Measurement is for Single Pixel ♦4 readout with the CCD at a temperature of -50°C and minimum exposure time under dark conditions.
- Quantum efficiency of the CCD sensor is measured by the CCD Manufacturer. ♦5
- The graph shows typical dark current level as a function of temperature for front-illuminated (FI) and back-illuminated (BI) CCDs. Systems are *****6 specified in terms of minimum dark current achievable rather than absolute temperature. The dark current measurement is averaged over the CCD area excluding any regions of blemishes.
- The max spectra/sec for spectroscopy CCDs is the maximum speed at which the device can acquire spectra in a standard system. It assumes a ♦7 1MHz digitization rate, internal trigger mode and full vertical binning. Also given is the rate for a 50 row high sub-image (crop mode) on a CCD in a standard system. Note that faster rates may be achieved by operating the CCD in Fast Kinetics mode.
- These power requirements are the maximum load that will be drawn from the computer for the camera head and controller card combined. ♦8
- ♦9 Specifications subject to change

Ordering Information:

To order this camera

quote model number DU440- FI: standard front-illuminated device

BU2: back-illuminated – AR coated for optimal performance in the 250 nm region

BV: back-illuminated – AR coated for optimal performance in the visible region

Need more information? Contact us at:

US Office *Phone* (860) 648-1085 Fax (860) 648-1088

International Office Phone +44 28 9023 7126 Fax +44 28 9031 0792

Japanese Office Phone +81 3 3511 0659 Fax +81 3 3239 8264